

AGILENT ATOMIC SPECTROSCOPY USER'S DAYS

MAY 31ST & JUNE 1ST 2017, EUROFINS ANALYTICO IN BARNEVELD, THE NETHERLANDS

AGENDA Day 1. Wednesday May 31st, 2017

Morning: Plenary session

- 09:00 – 09:30** **Registration with Welcome Coffee**
- 09:30 – 09:45** **WELCOME – Presenting Agilent**
TBD
- 09:45 – 10:05** **Agilent Services & Consumables**
Corne VANAERT, Agilent Technologies
- 10:05 – 10:30** **Agilent Atomic Spectroscopy Portfolio – Systems and innovations**
Yolande ADBELNOUR, Agilent Technologies
- 10:30 – 11:00** **Implementation of analytical solution for soil sample measurements using the Agilent 5110 ICP-OES**
Jean-Pierre LENER – Agilent Technologies
- 11:00 – 11:30** **COFFEEBREAK**
- 11:30 – 11:50** **High TDS analysis in routine laboratory**
Dennis KOPPELMAN, AKZO Hengelo
- 11:50 – 12:10** **Metal analysis in condensate via ICP-OES**
Bart DERVAUX, DOW Chemicals (with reservation)
- 12:10 – 12:30** **Improving productivity using the new developments on ICP-OES 5110 serie**
Wim PROPER – Eurofins Analytico
- 12:30 – 13:30** **LUNCH BREAK**
- 13:30 – 14:45** **Handsup on ICP OES Instrument,**
Lab session and Sample Analysis
- 14:45 – 15:15** **COFFEEBREAK**
- 15:15 – 16:30** **Session 2: Tips & Tricks**
Get the best out of your instruments
- 16:30** **Closing**



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AGILENT ATOMIC SPECTROSCOPY USER'S DAYS

MAY 31ST & JUNE 1ST 2017, EUROFINS ANALYTICO IN BARNEVELD, THE NETHERLANDS

AGENDA DAY 2. Thursday June 1st, 2017

Morning: Plenary session

- 09:00 – 09:30** **Registration with Welcome Coffee**
- 09:30 – 09:45** **WELCOME – Presenting Agilent**
TBD
- 09:45 – 10:05** **Agilent Services & Consumables**
Corne VANAERT, Agilent Technologies
- 10:05 – 10:30** **Agilent Atomic Spectroscopy Portfolio – Systems and innovations**
Yolande ADBELNOUR, Agilent Technologies
- 10:30 – 11:00** **ICP-MS/MS for the determination of elements at ultra-trace level in dissolved and nanoparticulate form**
Eduardo Bolea Fernández, University Ghent
- 11:00 – 11:30** **COFFEEBREAK**
- 11:30 – 11:50** **Trace element analysis in pyrophoric semiconductor products on low levels in the cleanroom**
Johan HOEKSTRA, AKZO Nobel Deventer
- 11:50 – 12:10** **Some examples of the use of ICP-MS in drug development**
Fred VAN HEUVELN, QPS
- 12:10 – 12:30** **Solution implementation for the analysis of Elemental impurities in compliance with ICH-Q3**
Jean-Pierre LENER, Agilent Technologies
- 12:30 – 13:30** **LUNCH BREAK**
- 13:30 – 14:45** **Session 1: Hands-on on ICP-MS and ICP-MS/MS Instruments**
Lab session and Sample analysis
- 14:45 – 15:15** **COFFEEBREAK**
- 15:15 – 16:30** **Session 2: Tips & Tricks**
Get the best out of your instruments
- 16:30** **Closing**



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